

# **FQN1N60CTA Datasheet**



https://www.DiGi-Electronics.com

DiGi Electronics Part Number FQN1N60CTA-DG

Manufacturer onsemi

Manufacturer Product Number FQN1N60CTA

Description MOSFET N-CH 600V 300MA T092-3

Detailed Description N-Channel 600 V 300mA (Tc) 1W (Ta), 3W (Tc) Throu

gh Hole TO-92-3



Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

DiGi is a global authorized distributor of electronic components.



# **Purchase and inquiry**

Manufacturer Product Number:	Manufacturer:
FQN1N60CTA	onsemi
Series:	Product Status:
QFET®	Obsolete
FET Type:	Technology:
N-Channel	MOSFET (Metal Oxide)
Drain to Source Voltage (Vdss):	Current - Continuous Drain (Id) @ 25°C:
600 V	300mA (Tc)
Drive Voltage (Max Rds On, Min Rds On):	Rds On (Max) @ ld, Vgs:
10V	11.50hm @ 150mA, 10V
Vgs(th) (Max) @ ld:	Gate Charge (Qg) (Max) @ Vgs:
4V @ 250μA	6.2 nC @ 10 V
Vgs (Max):	Input Capacitance (Ciss) (Max) @ Vds:
±30V	170 pF @ 25 V
FET Feature:	Power Dissipation (Max):
	1W (Ta), 3W (Tc)
Operating Temperature:	Mounting Type:
-55°C ~ 150°C (TJ)	Through Hole
Supplier Device Package:	Package / Case:
TO-92-3	TO-226-3, TO-92-3 (TO-226AA) Formed Leads
Base Product Number:	
EON1N60	

# **Environmental & Export classification**

8541.29.0095

RoHS Status:	Moisture Sensitivity Level (MSL):
ROHS3 Compliant	Not Applicable
REACH Status:	ECCN:
REACH Unaffected	EAR99
HTSUS:	

# $\frac{\text{MOSFET}}{\text{QFET}^{\text{\tiny{B}}}} - \text{N-Channel}$ QFET<sup>®</sup> 600 V, 0.3 A, 11.5 $\Omega$

## FQN1N60C

#### Description

This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

#### **Features**

- 0.3 A, 600 V,  $R_{DS(on)}$  = 11.5  $\Omega$  (Max.) @  $V_{GS}$  = 10 V,  $I_D$  = 0.15 A
- Low Gate Charge (Typ. 4.8 nC)
- Low Crss (Typ. 3.5 pF)
- 100% Avalanche Tested

#### **ABSOLUTE MAXIMUM RATINGS** (T<sub>C</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit	
$V_{DSS}$	Drain to Source Voltage	600	V	
$V_{GSS}$	Gate to Source Voltage		±30	V
I <sub>D</sub>	Drain Current Continuous (T <sub>C</sub> = 25°C) Continuous (T <sub>C</sub> = 100°C)		0.3 0.18	A
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	1.2	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	33	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	0.3	Α
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		0.3	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	V/ns
P <sub>D</sub>	Power Dissipation $(T_A = 25^{\circ}C)$ $(T_L = 25^{\circ}C)$ Derate above 25°C		1 3 0.02	W W W/°C
$T_J$ , $T_{STG}$	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300	°C

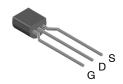
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. L = 59 mH,  $I_{AS}$  = 1.1 A,  $V_{DD}$  = 50 V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C.
- 3.  $I_{SD} \le 0.3$  A, di/dt  $\le 200$  A/ $\mu$ s,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25$ °C.

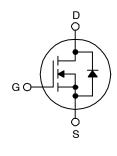


#### ON Semiconductor®

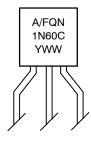
www.onsemi.com



TO-92 4.75x4.80 CASE 135AV



#### **MARKING DIAGRAM**



A = Assembly Site
FQN1N60C = Specific Device Code
Y = Year of Production
WW = Work Week Number

#### **ORDERING INFORMATION**

Device	Package	Shipping
FQN1N60CTA	TO-92 3LD	2000 / Fan-Fold

#### THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JL}$	Thermal Resistance, Junction-to-Lead, Max. (Note 5)	50	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction-to-Ambient, Max. (Note 6)	140	

#### **ELECTRICAL CHARACTERISTICS** ( $T_C = 25^{\circ}C$ , unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTIC			•	•	•
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	600	-	-	V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C	-	0.6	-	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V	_	-	50	μΑ
		V <sub>DS</sub> = 480 V, T <sub>C</sub> = 125°C	-	-	250	1
I <sub>GSSF</sub>	Gate to Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V	-	-	100	nA
I <sub>GSSR</sub>	Gate to Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V	ı	-	-100	nA
ON CHARA	CTERISTICS					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	-	4.0	V
R <sub>DS(on)</sub>	Static Drain to Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.15 A	-	9.3	11.5	Ω
9FS	Forward Transconductance	V <sub>DS</sub> = 40 V, I <sub>D</sub> = 0.3 A	1	0.75	-	S
DYNAMIC	CHARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	-	130	170	pF
C <sub>oss</sub>	Output Capacitance		-	19	25	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		ı	3.5	6	pF
SWITCHIN	G CHARACTERISTICS					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD}$ = 300 V, $I_D$ = 1.1 A, $R_G$ = 25 $\Omega$	_	7	24	ns
t <sub>r</sub>	Turn-On Rise Time	(Note 4)	-	21	52	ns
$t_{d(off)}$	Turn-Off Delay Time		-	13	36	ns
t <sub>f</sub>	Turn-Off Fall Time		-	27	64	ns
$Q_g$	Total Gate Charge	V <sub>DS</sub> = 480 V, I <sub>D</sub> = 1.1 A, V <sub>GS</sub> = 10 V	ı	4.8	6.2	nC
$Q_{gs}$	Gate to Source Charge	(Note 4)	ı	0.7	-	nC
$Q_{gd}$	Gate to Drain Charge		1	2.7	-	nC
DRAIN-SO	URCE DIODE CHARACTERISTICS AND M	AXIMUM RATINGS				
I <sub>S</sub>	Maximum Continuous Drain to Source Dio	de Forward Current	Ì	-	0.3	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	1.2	Α
V <sub>SD</sub>	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 0.3 A	-	-	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_{S} = 1.1 \text{ A, } dI_{F}/dt = 100 \text{ A/}\mu\text{s}$	-	190	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	]	-	0.53	-	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 4. Essentially independent of operating temperature.
- Essentially independent of operating temperature.
   Reference point of the R<sub>θJL</sub> is the drain lead.
   When mounted on 3"x4.5" FR-4 PCB without any pad copper in a still air environment (R<sub>θJA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance. R<sub>θCA</sub> is determined by the user's board design)

#### TYPICAL CHARACTERISTICS

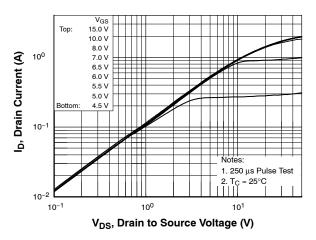


Figure 1. On-Region Characteristics

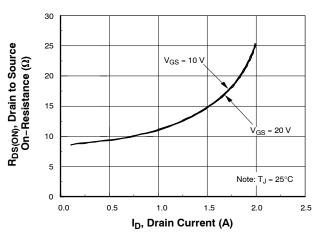


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

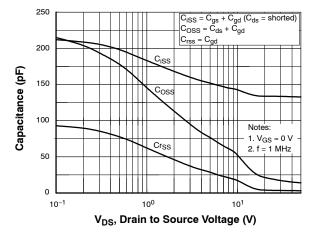


Figure 5. Capacitance Characteristics

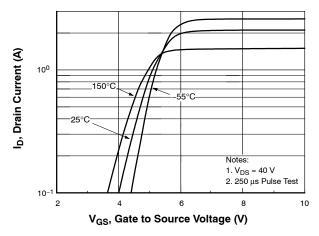


Figure 2. Transfer Characteristics

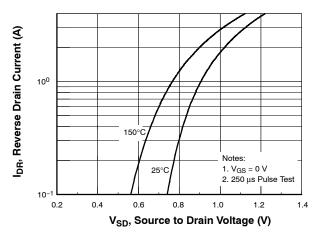


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

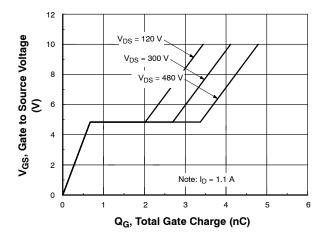


Figure 6. Gate Charge Characteristics

#### TYPICAL CHARACTERISTICS (Continued)

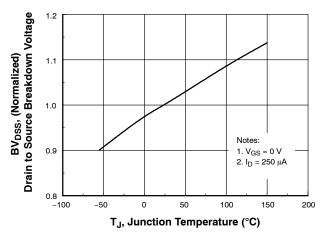


Figure 7. Breakdown Voltage Variation vs. Temperature

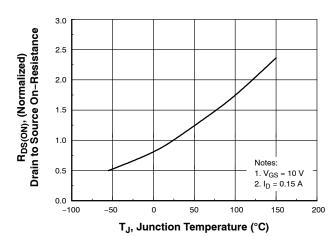


Figure 8. On–Resistance Variation vs. Temperature

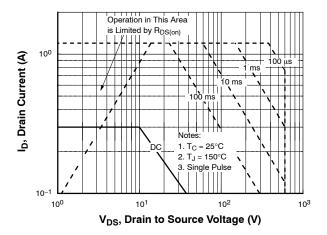


Figure 9. Maximum Safe Operating Area

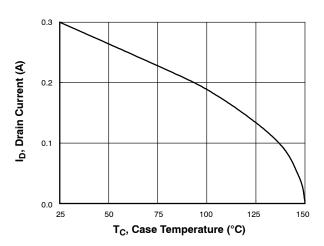


Figure 10. Maximum Drain Current vs. Case Temperature

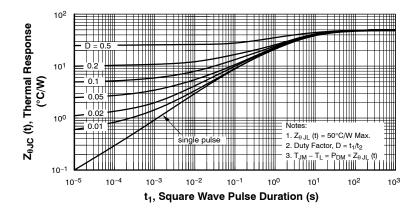


Figure 11. Transient Thermal Response Curve

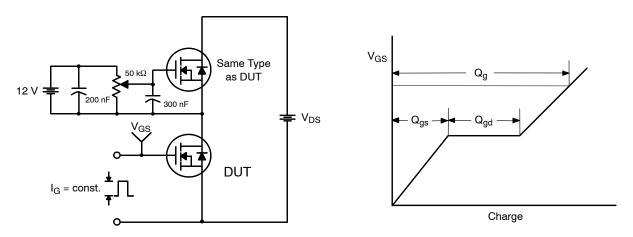


Figure 12. Gate Charge Test Circuit & Waveform

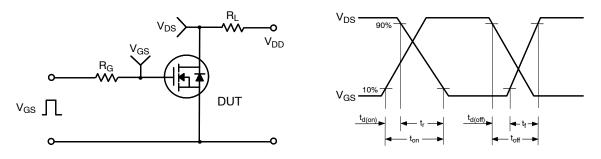


Figure 13. Resistive Switching Test Circuit & Waveforms

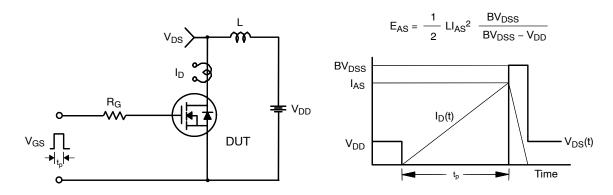
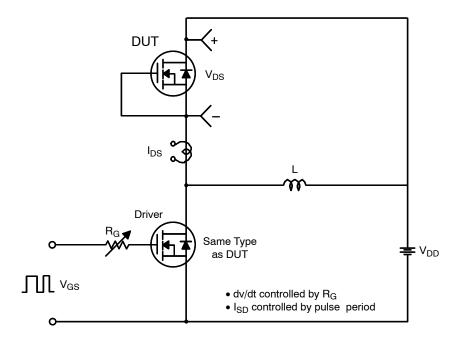


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



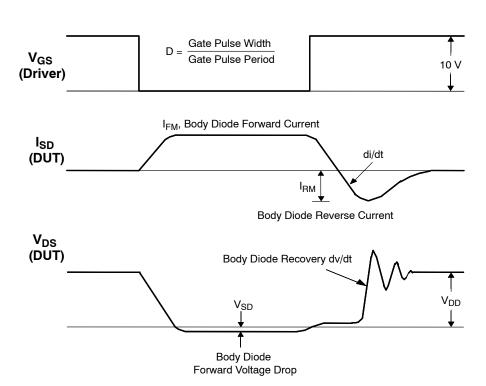
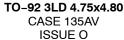


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

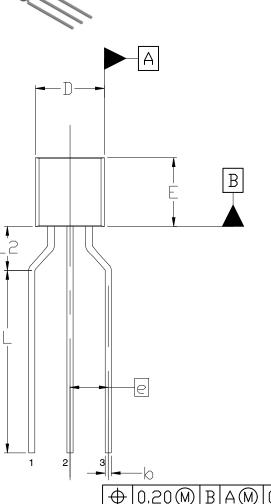


# **MECHANICAL CASE OUTLINE**

PACKAGE DIMENSIONS



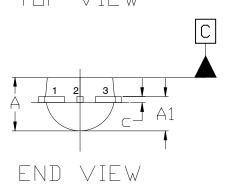
**DATE 07 JAN 2021** 



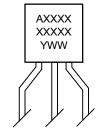
#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, GATE REMAINS AND TIE BAR PROTRUSIONS.

	MILLIMETERS				
DIM	MIN. NOM. MAX				
Α	3.05	3.60	4.19		
A1	2.13	2.50	2,88		
b	0.36	0,46	0.56		
C	0.30	0.40	0,52		
D	4.32	4.75	5,20		
Е	4.32	4.80	5,33		
6	2.54 BSC				
L	10.50	11.75	13.00		
L2	2.54		3,44		



#### **GENERIC MARKING DIAGRAM\***



XXXX = Specific Device Code = Assembly Location

= Year

WW = Work Week

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON29250H	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	TO-92 3LD 4.75X4.80		PAGE 1 OF 1

onsemi and Onsemi are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries, onsemi reserves the right to make changes without further notice to any products herein. **onsemi** makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that onsemi was negligent regarding the design or manufacture of the part. onsemi is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$ 

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales



### **OUR CERTIFICATE**

DiGi provide top-quality products and perfect service for customer worldwide through standardization, technological innovation and continuous improvement. DiGi through third-party certification, we striciy control the quality of products and services. Welcome your RFQ to Email: Info@DiGi-Electronics.com

















Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com